## Notice of References Cited Application/Control No. 10/015,235 Examiner Namitha Pillai Applicant(s)/Patent Under Reexamination DIETZ ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0033331 A1	. 02-2003	Sena et al.	707/513
	В	US-			
	C	US-			
	۵	US-			
	Е	US-			
	F	US-		·	
	O	US-			
	Ξ	US-			
	1	US-			
	7	US-			
	Κ	US-			
	L	US-			•
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
	0					
	Ρ					
	α					
	R					
	Ø					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
,	υ	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.